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What Are Embedded - Microcontrollers - Application Specific?

Application-specific microcontrollers are engineered to

Details	
Product Status	Obsolete
Applications	Automotive Mirror Control
Core Processor	HC08
Program Memory Type	FLASH (16kB)
Controller Series	908E
RAM Size	512 x 8
Interface	SCI, SPI
Number of I/O	16
Voltage - Supply	5.5V ~ 18V
Operating Temperature	-40°C ~ 85°C
Mounting Type	Surface Mount
Package / Case	54-BSSOP (0.295", 7.50mm Width)
Supplier Device Package	54-SOIC
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mm908e624acewr2

PIN CONNECTIONS

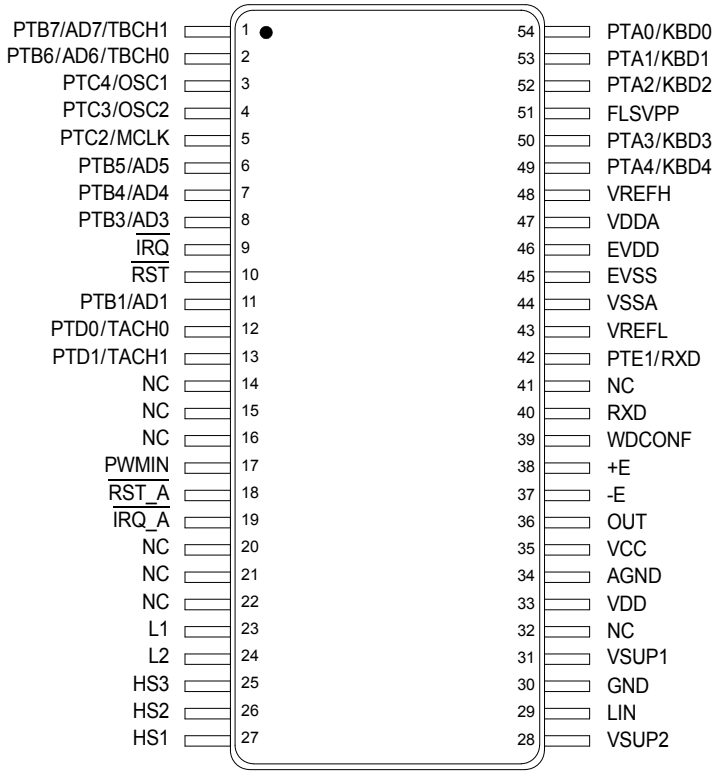


Figure 3. Pin Connections

Table 1. Pin Definitions

A functional description of each pin can be found in the Functional Pin Description section beginning on page 16.

Die	Pin	Pin Name	Formal Name	Definition
MCU	1 2 6 7 8 11	PTB7/AD7/TBCH1 PTB6/AD6/TBCH0 PTB5/AD5 PTB4/AD4 PTB3/AD3 PTB1/AD1	Port B I/Os	These pins are special function, bidirectional I/O port pins, that are shared with other functional modules in the MCU.
MCU	3 4 5	PTC4/OSC1 PTC3/OSC2 PTC2/MCLK	Port C I/Os	These pins are special function, bidirectional I/O port pins, that are shared with other functional modules in the MCU.
MCU	9	IRQ	External Interrupt Input	This pin is an asynchronous external interrupt input pin.
MCU	10	RST	External Reset	This pin is bidirectional, allowing a reset of the entire system. It is driven low when any internal reset source is asserted.
MCU	12 13	PTD0/TACH0 PTD1/TACH1	Port D I/Os	These pins are special function, bidirectional I/O port pins, that are shared with other functional modules in the MCU.
—	14, 15, 16, 20, 21, 22, 32, 41	NC	No Connect	Not connected.
MCU	42	PTE1/RXD	Port E I/O	This pin is a special function, bidirectional I/O port pin, that can is shared with other functional modules in the MCU.

Table 1. Pin Definitions (continued)

A functional description of each pin can be found in the Functional Pin Description section beginning on page 16.

Die	Pin	Pin Name	Formal Name	Definition
MCU	43 48	VREFL VREFH	ADC References	These pins are the reference voltage pins for the analog-to-digital converter (ADC).
MCU	44 47	VSSA VDDA	ADC Supply Pins	These pins are the power supply pins for the analog-to-digital converter.
MCU	45 46	EVSS EVDD	MCU Power Supply Pins	These pins are the ground and power supply pins, respectively. The MCU operates from a single power supply.
MCU	49 50 52 53 54	PTA4/KBD4 PTA3/KBD3 PTA2/KBD2 PTA1/KBD1 PTA0/KBD0	Port A I/Os	These pins are special function, bidirectional I/O port pins that are shared with other functional modules in the MCU.
MCU	51	FLSVPP	Test Pin	For test purposes only. Do not connect in the application.
Analog	17	PWMIN	Direct High Side Control Input	This pin allows the enabling and PWM control of the high side HS1 and HS2 pins.
Analog	18	RST_A	Internal Reset Output	This pin is the reset output pin of the analog die.
Analog	19	IRQ_A	Internal Interrupt Output	This pin is the interrupt output pin of the analog die indicating errors or wake-up events.
Analog	23 24	L1 L2	Wake-Up Inputs	These pins are the wake-up inputs of the analog chip.
Analog	25 26 27	HS3 HS2 HS1	High Side Output	These output pins are low $R_{DS(ON)}$ high side switches.
Analog	31 28	VSUP1 VSUP2	Power Supply Pins	These pins are device power supply pins.
Analog	29	LIN	LIN Bus	This pin represents the single-wire bus transmitter and receiver.
Analog	30 34	GND AGND	Power Ground Pins	These pins are device power ground connections.
Analog	33	VDD	Voltage Regulator Output	The +5.0 V voltage regulator output pin is intended to supply the embedded microcontroller.
Analog	35	VCC	Amplifier Power Supply	This pin is the single +5.0 V power supply for the current sense operational amplifier.
Analog	36	OUT	Amplifier Output	This pin is the output of the current sense operational amplifier.
Analog	37 38	-E +E	Amplifier Inputs	These pins are the current sense operational amplifier inverted and non-inverted inputs.
Analog	39	WDCONF	Window Watchdog Configuration Pin	This input pin is for configuration of the watchdog period and allows the disabling of the watchdog.
Analog	40	RXD	LIN Transceiver Output	This pin is the output of LIN transceiver.

STATIC ELECTRICAL CHARACTERISTICS

Table 3. Static Electrical Characteristics

All characteristics are for the analog chip only. Refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V ≤ V_{SUP} ≤ 16 V, -40 °C ≤ T_J ≤ 125 °C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T_A = 25°C under nominal conditions, unless otherwise noted.

Characteristic	Symbol	Min	Typ	Max	Unit
SUPPLY VOLTAGE RANGE					
Nominal Operating Voltage	V_{SUP}	5.5	—	18	V
Functional Operating Voltage (6)	V_{SUPOP}	—	—	27	V
SUPPLY CURRENT RANGE					
Normal Mode (7) V_{SUP} = 13.5 V, Analog Chip in Normal Mode, MCU Operating Using Internal Oscillator at 32 MHz (8.0 MHz Bus Frequency), SPI, ESCI, ADC Enabled	I_{RUN}	—	20	—	mA
Stop Mode (7), (8) V_{SUP} = 13.5 V, LIN in recessive state	I_{STOP}	—	60	75	µA
Sleep Mode (7), (8) V_{SUP} = 13.5 V, LIN in recessive state	I_{SLEEP}	—	35	45	µA
DIGITAL INTERFACE RATINGS (ANALOG DIE)					
Output Pin $\overline{RST\_A}$					
Low-state Output Voltage (I_{OUT} = -1.5 mA)	V_{OL}	—	—	0.4	V
High-state Output Current (V_{OUT} > 3.5 V)	I_{OH}	—	250	—	µA
Pull-down Current Limitation	I_{OL_MAX}	-1.5	—	-8.0	mA
Output Pin $\overline{IRQ\_A}$					V
Low-state Output Voltage (I_{OUT} = -1.5 mA)	V_{OL}	—	—	0.4	
High-state Output Voltage (I_{OUT} = 250 µA)	V_{OH}	3.85	—	—	
Output Pin RXD					
Low-state Output Voltage (I_{OUT} = -1.5 mA)	V_{OL}	—	—	0.4	V
High-state Output Voltage (I_{OUT} = 250 µA)	V_{OH}	3.85	—	—	V
Capacitance (9)	C_{IN}	—	4.0	—	pF
Input Pin PWMIN					
Input Logic Low Voltage	V_{IL}	—	—	1.5	V
Input Logic High Voltage	V_{IH}	3.5	—	—	V
Input Current	I_{IN}	-10	—	10	µA
Capacitance (9)	C_{IN}	—	4.0	—	pF
Pin TXD, $\overline{SS}$–Pull-up Current	I_{PU}	—	40	—	µA

Notes

6. Device is fully functional. All functions are operating. Over-temperature may occur.
7. Total current (I_{VSUP1} + I_{VSUP2}) measured at GND pin.
8. Stop and Sleep mode current will increase if V_{SUP} exceeds 15 V.
9. This parameter is guaranteed by process monitoring but is not production tested.

Table 3. Static Electrical Characteristics (continued)

All characteristics are for the analog chip only. Refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V ≤ V_{SUP} ≤ 16 V, -40 °C ≤ T_J ≤ 125 °C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T_A = 25°C under nominal conditions, unless otherwise noted.

Characteristic	Symbol	Min	Typ	Max	Unit
SYSTEM RESETS AND INTERRUPTS					
Low-voltage Reset (LVR) Threshold	V_{LVRON}	3.6	4.0	4.4	V
Low-voltage Interrupt (LVI) Threshold Hysteresis	 V_{LVI} V_{LVI_HYS}	 5.7 —	 6.0 1.0	 6.6 —	V
High-voltage Interrupt (HVI) Threshold Hysteresis	 V_{HVI} V_{HVI_HYS}	 18 —	 19.25 220	 20.5 —	 V mV
VOLTAGE REGULATOR (10)					
Normal Mode Output Voltage 2.0 mA < I_{DD} < 50 mA, 5.5 V < V_{SUP} < 27 V	V_{DDRUN}	4.75	5.0	5.25	V
Normal Mode Output Current Limitation (11)	I_{DDRUN}	50	110	200	mA
Dropout Voltage V_{SUP} = 4.9 V, I_{DD} = 50 mA	V_{DDDROP}	—	0.1	0.2	V
Stop Mode Output Voltage (12)	V_{DDSTOP}	4.75	5.0	5.25	V
Stop Mode Regulator Current Limitation	I_{DDSTOP}	4.0	8.0	14	mA
Line Regulation Normal Mode, 5.5 V < V_{SUP} < 27 V, I_{DD} = 10 mA Stop Mode, 5.5 V < V_{SUP} < 27 V, I_{DD} = 2.0 mA	 V_{LRRUN} V_{LRSTOP}	 — —	 20 10	 150 100	mV
Load Regulation Normal Mode, 1.0 mA < I_{DD} < 50 mA, V_{SUP} = 18 V Stop Mode, 1.0 mA < I_{DD} < 5.0 mA, V_{SUP} = 18 V	 V_{LRRUN} V_{LDSTOP}	 — —	 40 40	 150 150	mV
Over-temperature Prewarning (Junction) (13)	T_{PRE}	120	135	160	°C
Thermal Shutdown Temperature (Junction) (13)	T_{SD}	155	170	—	°C
Temperature Threshold Difference T_{SD}-T_{PRE}	ΔT_{SD}-T_{PRE}	20	30	45	°C

Notes

10. Specification with external capacitor 2.0 μF< C < 10 μF and 200 mΩ ≤ ESR ≤ 10 Ω. Capacitor value up to 47 μF can be used.
11. Total V_{DD} regulator current. A 5.0 mA current for current sense operational amplifier is included. Digital output supplied from VDD.
12. When switching from Normal to Stop mode or from Stop mode to Normal mode, the output voltage can vary within the output voltage specification.
13. This parameter is guaranteed by process monitoring but not production tested

Table 3. Static Electrical Characteristics (continued)

All characteristics are for the analog chip only. Refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V ≤ V_{SUP} ≤ 16 V, -40 °C ≤ T_J ≤ 125 °C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T_A = 25°C under nominal conditions, unless otherwise noted.

Characteristic	Symbol	Min	Typ	Max	Unit
HIGH SIDE OUTPUT HS3					
Switch On Resistance	$R_{DS(ON)}$				Ω
T_J = 25 °C, I_{LOAD} = 50 m A, V_{SUP} > 9.0 V		—	—	7.0	
T_J = 125 °C, I_{LOAD} = 50 mA, V_{SUP} > 9.0 V		—	—	10	
T_J = 125 °C, I_{LOAD} = 30 mA, 5.5 V < V_{SUP} > 9.0 V		—	—	14	
Output Current Limitation	I_{LIM}	60	100	200	mA
Over-temperature Shutdown (17), (18)	T_{HSSD}	155	—	190	°C
Leakage Current	I_{LEAK}	—	—	10	µA
CURRENT SENSE OPERATIONAL AMPLIFIER					
Rail-to-Rail Input Voltage	V_{IMC}	-0.1	—	V_{CC}+0.1	V
Output Voltage Range					V
Output Current ±1.0 mA	V_{OUT1}	0.1	—	V_{CC}-0.1	
Output Current ±5.0 mA	V_{OUT2}	0.3	—	V_{CC}-0.3	
Input Bias Current	I_B	—	—	250	nA
Input Offset Current	I_O	-100	—	100	nA
Input Offset Voltage	V_{IO}	-25	—	25	mV
L1 AND L2 INPUTS					
Low Detection Threshold	V_{THL}				V
5.5 V < V_{SUP} < 6.0 V		2.0	2.5	3.0	
6.0 V < V_{SUP} < 18 V		2.5	3.0	3.5	
18 V < V_{SUP} < 27 V		2.7	3.2	3.7	
High Detection Threshold	V_{THH}				V
5.5 V < V_{SUP} < 6.0 V		2.7	3.3	3.8	
6.0 V < V_{SUP} < 18 V		3.0	4.0	4.5	
18 V < V_{SUP} < 27 V		3.5	4.2	4.7	
Hysteresis	V_{HYS}				V
5.5 V < V_{SUP} < 27 V		0.5	—	1.3	
Input Current	I_{IN}				µA
-0.2 V < V_{IN} < 40 V		-10	—	10	

Notes
17. This parameter is guaranteed by process monitoring but it is not production tested
18. When over-temperature occurs, switch is turned off and latched off. Flag is set in SPI.

Table 4. Dynamic Electrical Characteristics (continued)

All characteristics are for the analog chip only. Please refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V ≤ V_{SUP} ≤ 16 V, -40 °C ≤ T_J ≤ 125 °C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T_A = 25 °C under nominal conditions, unless otherwise noted.

Characteristic	Symbol	Min	Typ	Max	Unit
CURRENT SENSE OPERATIONAL AMPLIFIER					
Supply Voltage Rejection Ratio (29)	SVR	60	—	—	dB
Common Mode Rejection Ratio (29)	CMR	70	—	—	dB
Gain Bandwidth (29)	GBP	1.0	—	—	MHz
Slew Rate	SR	0.5	—	—	V/μs
Phase Margin (for Gain = 1, Load 100 pF/ 5.0 kΩ (29)	PHMO	40	—	—	°
Open Loop Gain	OLG	—	85	—	dB

Notes

29. This parameter is guaranteed by process monitoring but it is not production tested.

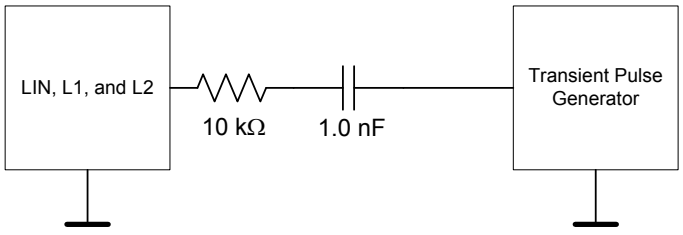
MICROCONTROLLER PARAMETRICS

Table 5. Microcontroller

For a detailed microcontroller description, refer to the MC68HC908EY16 data sheet.

Module	Description
Core	High-Performance HC08 Core with a Maximum Internal Bus Frequency of 8.0 MHz
Timer	Two 16-Bit Timers with 2 Channels (TIM A and TIM B)
Flash	16 K Bytes
RAM	512 Bytes
ADC	10-Bit Analog-to-Digital Converter
SPI	SPI Module
ESCI	Standard Serial Communication Interface (SCI) Module Bit-Time Measurement Arbitration Prescaler with Fine Baud-Rate Adjustment
ICG	Internal Clock Generation Module

TIMING DIAGRAMS



Note Waveform in accordance with ISO7637 Part 1, Test Pulses 1, 2, 3a, and 3b.

Figure 4. Test Circuit for Transient Test Pulses

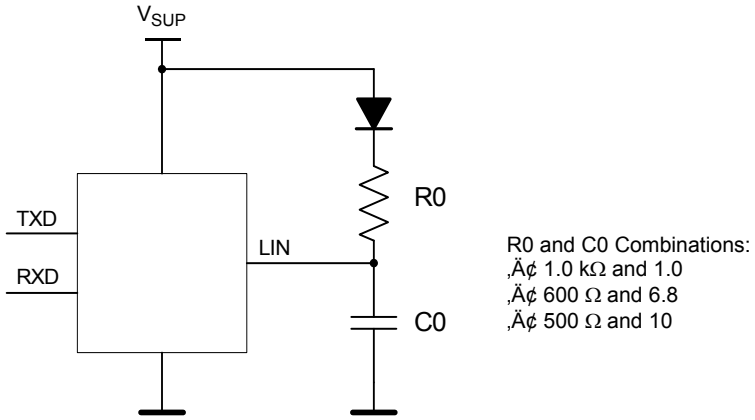


Figure 5. Test Circuit for LIN Timing Measurements

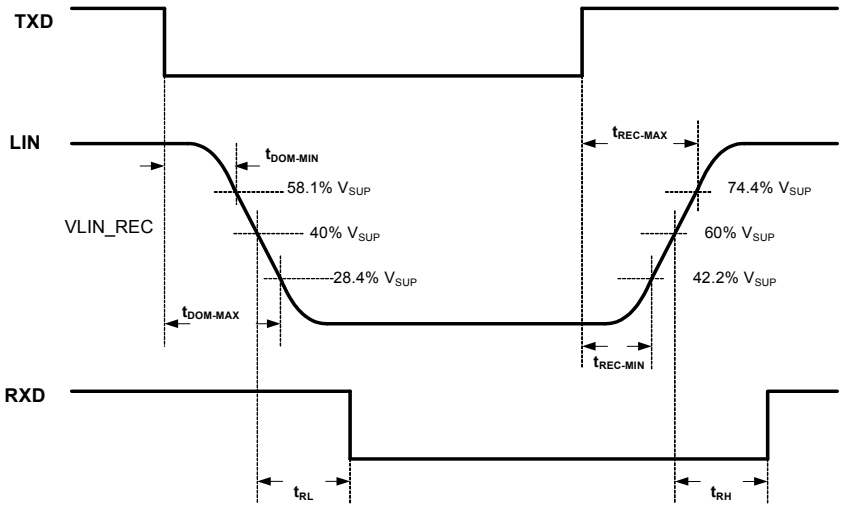


Figure 6. LIN Timing Measurements for Normal Slew Rate

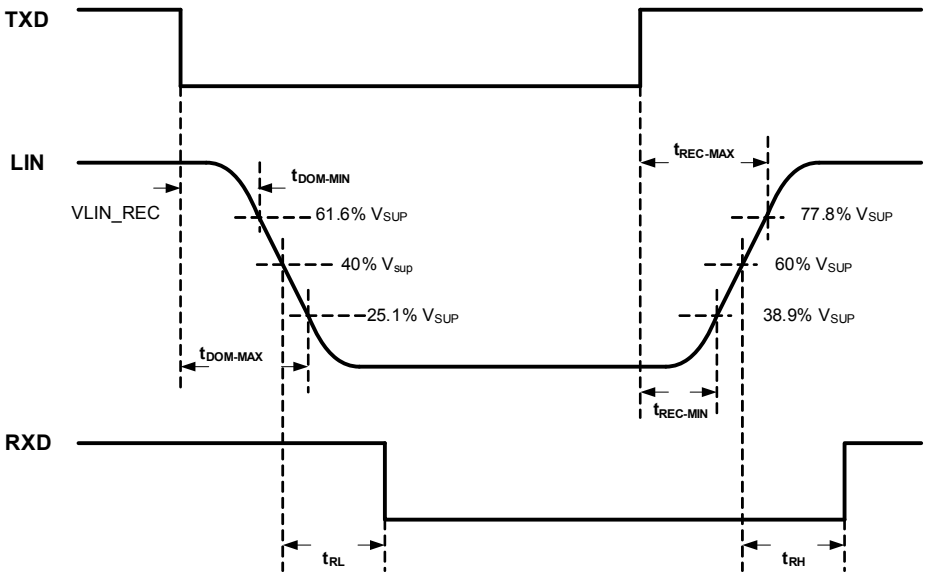


Figure 7. LIN Timing Measurements for Slow Slew Rate

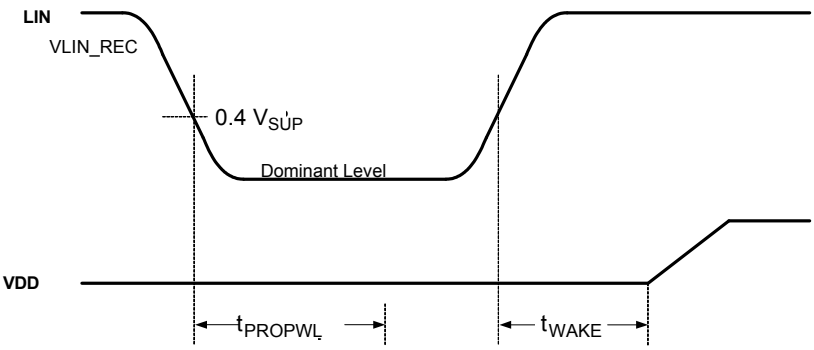


Figure 8. Wake-up Sleep Mode Timing

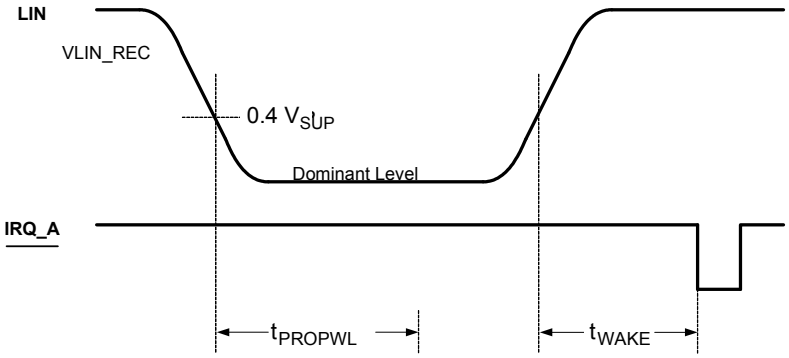


Figure 9. Wake-up Stop Mode Timing

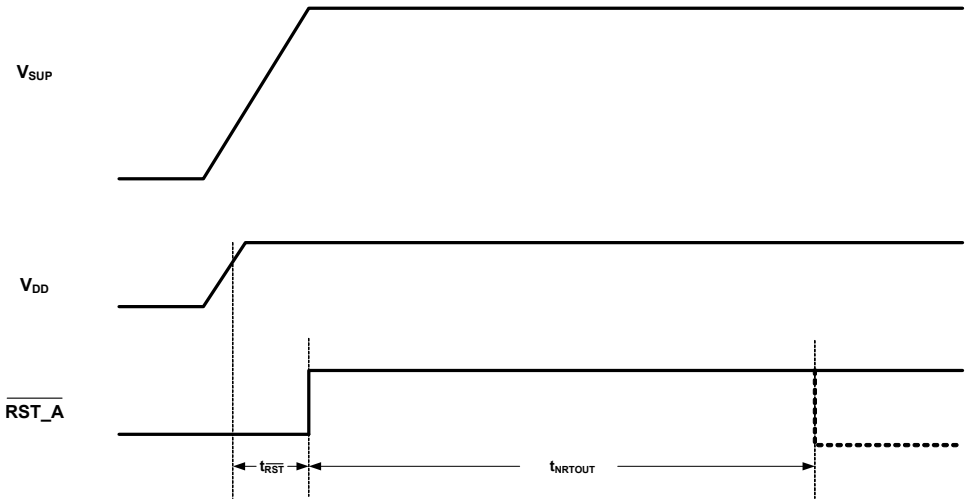


Figure 10. Power On Reset and Normal Request Timeout Timing

Note If the operational amplifier is not used, it is possible to connect all pins (E+, E-, OUT and VCC) to GND. In this case, all of the four pins must be grounded.

+5.0 V VOLTAGE REGULATOR OUTPUT PIN (VDD)

The VDD pin is needed to place an external capacitor to stabilize the regulated output voltage. The VDD pin is intended to supply the embedded microcontroller. The pin is protected against shorts to GND with an integrated current limit (temperature shutdown could occur).

Important The VDD, EVDD, VDDA, and VREFH pins must be connected together.

VOLTAGE REGULATOR AND CURRENT SENSE AMPLIFIER GROUND PIN (AGND)

The AGND pin is the ground pin of the voltage regulator and the current sense operational amplifier.

Important GND, AGND, VSS, EVSS, VSSA, and VREFL pins must be connected together.

NO CONNECT PINS (NC)

The NC pins are not connected internally.

Note Each of the NC pins can be left open or connected to ground (recommended).

Table 6. Operating Modes Overview

Device Mode	Voltage Regulator	Wake-up Capabilities	$\overline{\text{RST\_A}}$ Output	Watchdog Function	HS1, HS2, and HS3	LIN Interface	Sense Amplifier
Reset	V_{DD} ON	N/A	LOW	Disabled	Disabled	Recessive only	Not active
Normal Request	V_{DD} ON	N/A	HIGH	150 ms time out if WD enabled	Enabled	Transmit and receive	Not active
Normal (Run)	V_{DD} ON	N/A	HIGH	Window WD if enabled	Enabled	Transmit and receive	Active
Stop	V_{DD} ON with limited current capability	LIN wake-up, L1, L2 state change, $\overline{\text{SS}}$ rising edge	HIGH	Disabled	Disabled	Recessive state with wake-up capability	Not active
Sleep	V_{DD} OFF	LIN wake-up L1, L2 state change	LOW	Disabled	Disabled	Recessive state with wake-up capability	Not active

INTERRUPTS

In Normal (Run) mode the 908E624 has four different interrupt sources. An interrupt pulse on the $\overline{\text{IRQ\_A}}$ pin is generated to report a fault to the MCU. All interrupts are not maskable and cannot be disabled.

After an Interrupt the INTSRC bit in the SPI Status register is set, indicating the source of the event. This interrupt source information is only transferred once, and the INTSRC bit is cleared automatically.

Low-Voltage Interrupt

Low-voltage interrupt (LVI) is related to external supply voltage VSUP1. If this voltage falls below the LVI threshold, it will set the LVF bit in the SPI Status register and an interrupt will be initiated. The LVF bit remains set as long as the Low-voltage condition is present.

During Sleep and Stop mode the low-voltage interrupt circuitry is disabled.

High-voltage Interrupt

High-voltage interrupt (HVI) is related to external supply voltage VSUP1. If this voltage rises above the HVI threshold, it will set the HVF bit in the SPI Status register and an interrupt will be initiated. The HVF bit remains set as long as the high-voltage condition is present.

During Sleep and Stop mode the high-voltage interrupt circuitry is disabled.

Wake-up Interrupts

In Stop mode the $\overline{\text{IRQ\_A}}$ pin reports wake-up events on the L1, L2, or the LIN bus to the MCU. All wake-up interrupts are not maskable and cannot be disabled.

After a wake-up interrupt, the INTSRC bit in the Serial Peripheral Interface (SPI) Status register is set, indicating the source of the event. This wake-up source information is only transferred once, and the INTSRC bit is cleared automatically.

Figure 12, page 21, describes the Stop/Wake-up procedure.

Voltage Regulator Temperature Prewarning (VDDT)

Voltage regulator temperature prewarning (VDDT) is generated if the voltage regulator temperature is above the T_{PRE} threshold. It will set the VDDT bit in the SPI Status register and an interrupt will be initiated. The VDDT bit remains set as long as the error condition is present.

During Sleep and Stop mode the voltage regulator temperature prewarning circuitry is disabled.

High Side Switch Thermal Shutdown (HSST)

The high side switch thermal shutdown HSST is generated if one of the high side switches HS1:HS3 is above the HSST threshold, it will shutdown all high side switches, set the HSST flag in the SPI Status register and an interrupt will be initiated. The HSST bit remains set as long as the error condition is present.

During Sleep and Stop mode the high side switch thermal shutdown circuitry is disabled.

The LIN pin offers high susceptibility immunity level from external disturbance, guaranteeing communication during external disturbance.

The LIN transmitter circuitry is enabled in Normal and Normal Request mode.

An over-current condition (e.g. LIN bus short to V_{BAT}) or a over-temperature in the output low side FET will shutdown the transmitter and set the LINFAIL flag in the SPI Status Register.

For improved performance and safe behavior in case of LIN bus short to Ground or LIN bus leakage during low power mode the internal pull-up resistor on the LIN pin can be disconnected, with the LIN-PU bit in the SPI Control Register, and a small current source keeps the LIN bus at recessive level. In case of a LIN bus short to GND, this feature will reduce the current consumption in STOP and SLEEP modes.

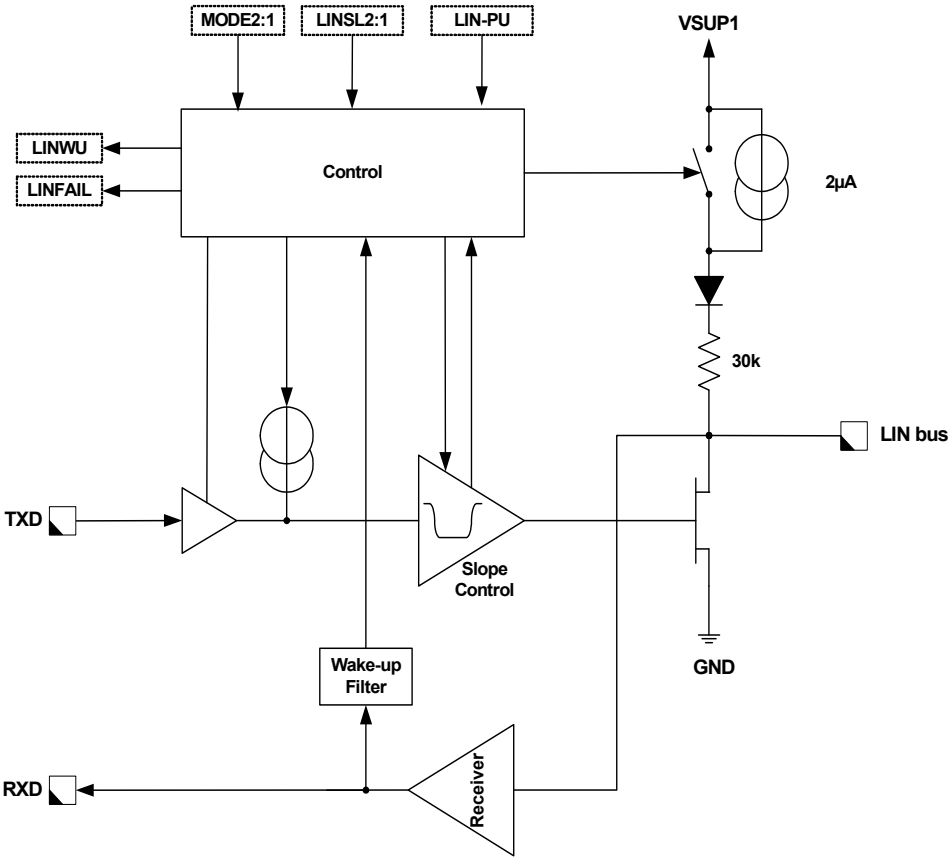


Figure 15. LIN Interface

TXD Pin

The TXD pin is the MCU interface to control the state of the LIN transmitter (see Figure 2, page 2). When TXD is LOW, the LIN pin is low (dominant state). When TXD is HIGH, the LIN output MOSFET is turned off (recessive state). The TXD pin has an internal pull-up current source in order to set the LIN bus to recessive state in the event, for instance, the microcontroller could not control it during system power-up or power-down.

RXD Pin

The RXD transceiver pin is the MCU interface, which reports the state of the LIN bus voltage. LIN HIGH (recessive state) is reported by a high level on RXD, LIN LOW (dominant state) by a low level on RXD.

STOP Mode and Wake-up Feature

During STOP mode operation the transmitter of the physical layer is disabled. In case the bit LIN-PU was set in the Stop mode sequence the internal pull-up resistor is disconnected from VSUP and a small current source keeps the LIN pin in recessive state. The receiver is still active and able to detect wake-up events on the LIN bus line.

A dominant level longer than t_{PROPWL} followed by an rising edge will generate a wake-up interrupt and set the LINWF flag in the SPI Status Register. Also see Figure 9, page 15.

SLEEP Mode and Wake-up Feature

During SLEEP mode operation the transmitter of the physical layer is disabled. In case the bit LIN-PU was set in the Sleep mode sequence the internal pull-up resistor is

LOGIC COMMANDS AND REGISTERS

908E624 SPI INTERFACE AND CONFIGURATION

The serial peripheral interface creates the communication link between the microcontroller and the analog die of the 908E624.

The interface consists of four pins (see Figure 17):

- $\overline{SS}$—Slave Select
- MOSI—Master-Out Slave-In
- MISO—Master-In Slave-Out
- SPSCK—Serial Clock

A complete data transfer via the SPI consists of 1 byte. The master sends 8 bits of control information and the slave replies with 8 bits of status data.

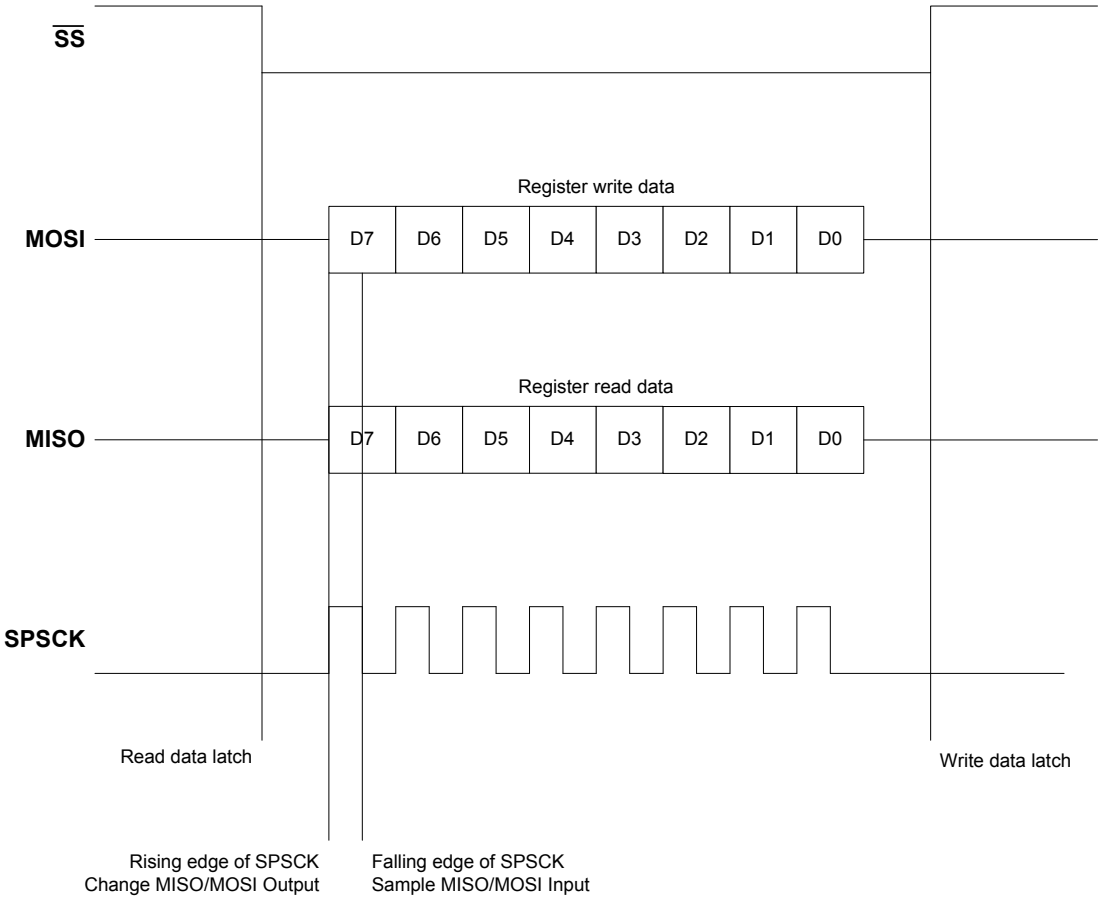


Figure 17. SPI Protocol

During the inactive phase of the $\overline{SS}$ (HIGH), the new data transfer is prepared.

The falling edge of the $\overline{SS}$ indicates the start of a new data transfer and puts the MISO in the low-impedance state and latches the analog status data (Register read data).

With the rising edge of the SPI clock, SPSCK the data is moved to MISO/MOSI pins. With the falling edge of the SPI clock SPSCK the data is sampled by the Receiver.

The data transfer is only valid if exactly 8 sample clock edges are present in the active (low) phase of $\overline{SS}$.

The rising edge of the slave select $\overline{SS}$ indicates the end of the transfer and latches the write data (MOSI) into the register The $\overline{SS}$ high forces MISO to the high-impedance state.

SPI REGISTER OVERVIEW

Table 7 summarizes the SPI Register bit meaning, reset value, and bit reset condition.

Stop Mode Sequence

The Stop command, as shown in Table 12, must be sent twice.

Table 12. Stop Command Bits

LINSL2	LINSL1	LIN-PU	HS3ON	HS2ON	HS1ON	MODE2	MODE1
1	1	0/1	0	0	0	0	1

SPI Status Register (Read)

Table 13 shows the SPI Status register bits by name.

Table 13. Control Bits Function (Read Operation)

D7	D6	D5	D4	D3	D2	D1	D0
INTSRC	LINWU or LINFAIL	HVF	LVF or BATFAIL	VDDT	HSST	L2	L1

INTSCR—Register Content Flags or Interrupt Source

This bit indicates if the register contents reflect the flags or an interrupt/wake-up interrupt source.

- 1 = D6:D0 reflects the interrupt or wake-up source.
- 0 = No interrupt occurred. Other SPI bits report real time status.

LINWU/LINFAIL—LIN Status Flag Bit

This bit indicates a LIN wake-up condition.

- 1 = LIN bus wake-up occurred or LIN over-current/over-temperature occurred.
- 0 = No LIN bus wake-up occurred.

In case of a LIN over-current/over-temperature condition the LIN transmitter is disabled. To reenable the LIN transmitter, the error condition must be GONE and the LINWU/LINFAIL flag must be cleared.

The flag is cleared by reading the flag when it is set (SPI command).

HVF —High-voltage Flag Bit

This flag is set on an over-voltage (VSUP1) condition.

- 1 = High-voltage condition has occurred.
- 0 = no High-voltage condition.

LVF/BATFAIL—Low-voltage Flag Bit

This flag is set on an under-voltage (VSUP1) condition.

- 1 = Low-voltage condition has occurred.
- 0 = No low-voltage condition.

VDDT—Voltage Regulator Status Flag Bit

This flag is set as prewarning in case of an over-temperature condition on the voltage regulator.

- 1 = Voltage regulator over-temperature condition, prewarning.
- 0 = No over-temperature detected.

HSST—High Side Status Flag Bit

This flag is set on over-temperature conditions on one of the high side outputs.

- 1 = HSx off due to over-temperature.
- 0 = No over-temperature.

In case one of the high sides has an over-temperature condition all high side switches are disabled.

To reenable the high side switches, the flags have to be cleared, by reading the flag when it is set and by writing a one to high side HSxON bit (two SPI commands are necessary).

L2:L1—Wake-up Inputs L1, L2 Status Flag Bit

These flags reflect the status of the L2 and L1 input pins and indicate the wake-up source.

- 1 = L2:L1 input high or wake-up by L2:L1 (first register read after wake-up indicated with INTSRC = 1).
- 0 = L2:L1 input low.

TYPICAL APPLICATIONS

DEVELOPMENT SUPPORT

As the 908E624 has the MC68HC908EY16 MCU embedded typically all the development tools available for the MCU also apply for this device, however due to the fact of the additional analog die circuitry and the nominal +12 V supply voltage some additional items have to be considered:

- nominal 12 V rather than 5.0 or 3.0 V supply
- high voltage V_{TST} might be applied not only to $\overline{IRQ}$ pin, but $\overline{IRQ\_A}$ pin
- MCU monitoring (Normal request timeout) has to be disabled

For a detailed information on the MCU related development support see the MC68HC908EY16 data sheet - section development support.

The programming is principally possible at two stages in the manufacturing process — first on chip level, before the IC is soldered onto a PCB board and second after the IC is soldered onto the PCB board.

Chip Level Programming

On Chip level the easiest way is to only power the MCU with +5.0 V (see Figure 18) and not to provide the analog chip with VSUP, in this setup all the analog pin should be left open (e.g. VSUP[1:2]) and interconnections between MCU and analog die have to be separated (e.g. $\overline{IRQ}$ - $\overline{IRQ\_A}$).

This mode is well described in the MC68HC908EY16 data sheet - section development support.

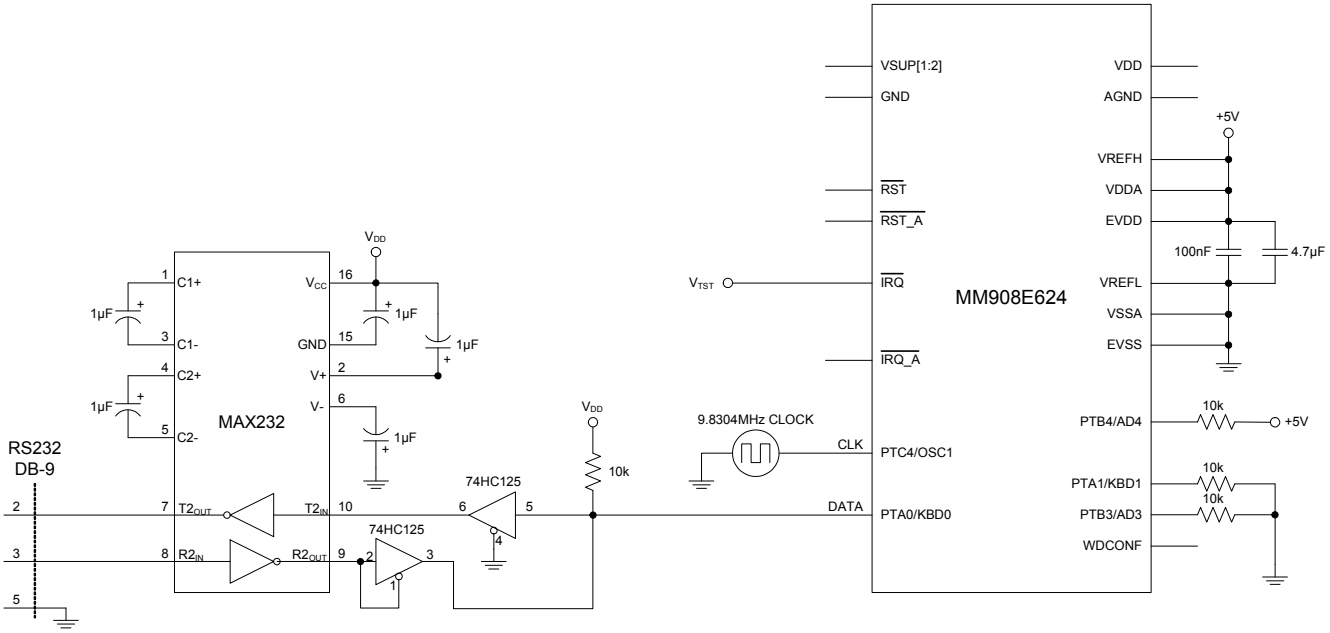


Figure 18. Normal Monitor Mode Circuit (MCU only)

Of course it is also possible to supply the whole system with VSUP (12 V) instead as described in Figure 19, page 29.

EMC/EMI RECOMMENDATIONS

This paragraph gives some device specific recommendations to improve EMC/EMI performance. Further generic design recommendations can be found on the Freescale website: www.freescale.com.

VSUP Pins (VSUP1 and VSUP2)

Its recommended to place a high quality ceramic decoupling capacitor close to the VSUP pins to improve EMC/EMI behavior.

LIN Pin

For DPI (Direct Power Injection) and ESD (Electro Static Discharge) it is recommended to place a high quality ceramic decoupling capacitor near the LIN pin. An additional varistor will further increase the immunity against ESD. A ferrite in the LIN line will suppress some of the noise induced.

Voltage Regulator Output Pins (VDD and AGND)

Use a high quality ceramic decoupling capacitor to stabilize the regulated voltage.

MCU Digital Supply Pins (EVDD and EVSS)

Fast signal transitions on MCU pins place high, short duration current demands on the power supply. To prevent noise problems, take special care to provide power supply bypassing at the MCU. It is recommended that a high quality ceramic decoupling capacitor be placed between these pins.

MCU Analog Supply Pins (VREFH, VDDA, VREFL, and VSSA)

To avoid noise on the analog supply pins it is important to take special care on the layout. The MCU digital and analog supplies should be tied to the same potential via separate traces and connected to the voltage regulator output.

Figure 20 and Figure 21 show the recommendations on schematics and layout level and Table 15 indicates recommended external components and layout considerations.

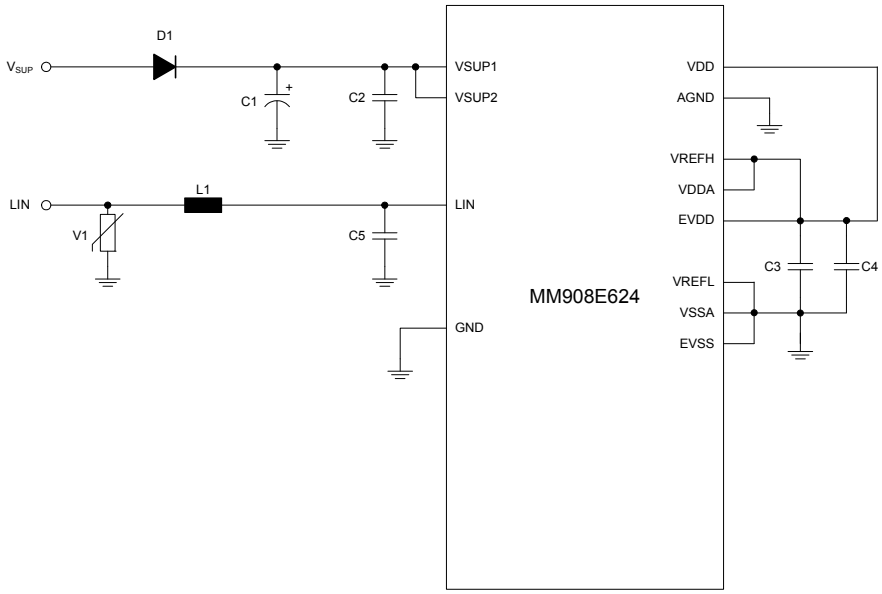
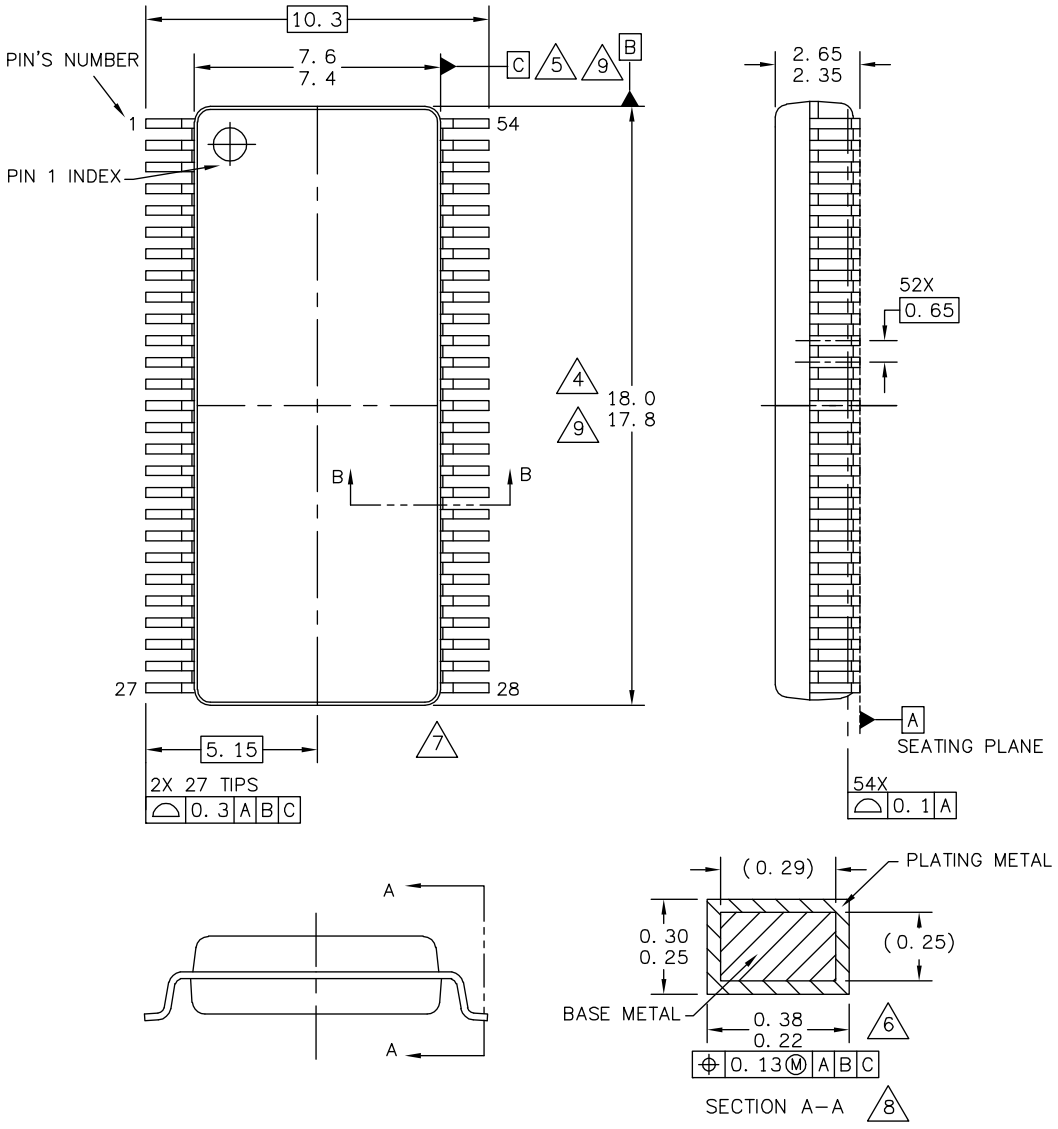


Figure 20. EMC/EMI Recommendations

PACKAGING

PACKAGING DIMENSIONS

Important For the most current revision of the package, visit www.freescale.com and do a keyword search on the 98ASA99294D drawing number below. Dimensions shown are provided for reference ONLY.



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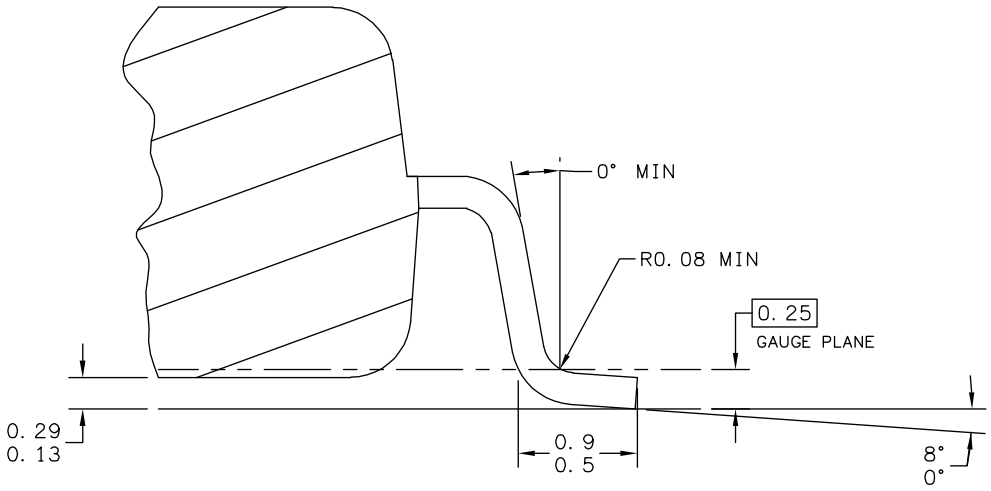
TITLE: 54LD SOIC W/B, 0.65 PITCH CASE-OUTLINE	DOCUMENT NO: 98ASA99294D	REV: B
	CASE NUMBER: 1365-01	12 APR 2005
	STANDARD: NON-JEDEC	

EW SUFFIX (Pb-FREE)
54-Pin SOIC WIDE BODY
98ASA99294D
ISSUE B

908E624



SECTION B–B

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TITLE: 54LD SOIC W/B, 0.65 PITCH CASE–OUTLINE	DOCUMENT NO: 98ASA99294D	REV: B
	CASE NUMBER: 1365–01	12 APR 2005
	STANDARD: NON–JEDEC	

EW SUFFIX (Pb-FREE)
54-Pin SOIC WIDE BODY
98ASA99294D
ISSUE B

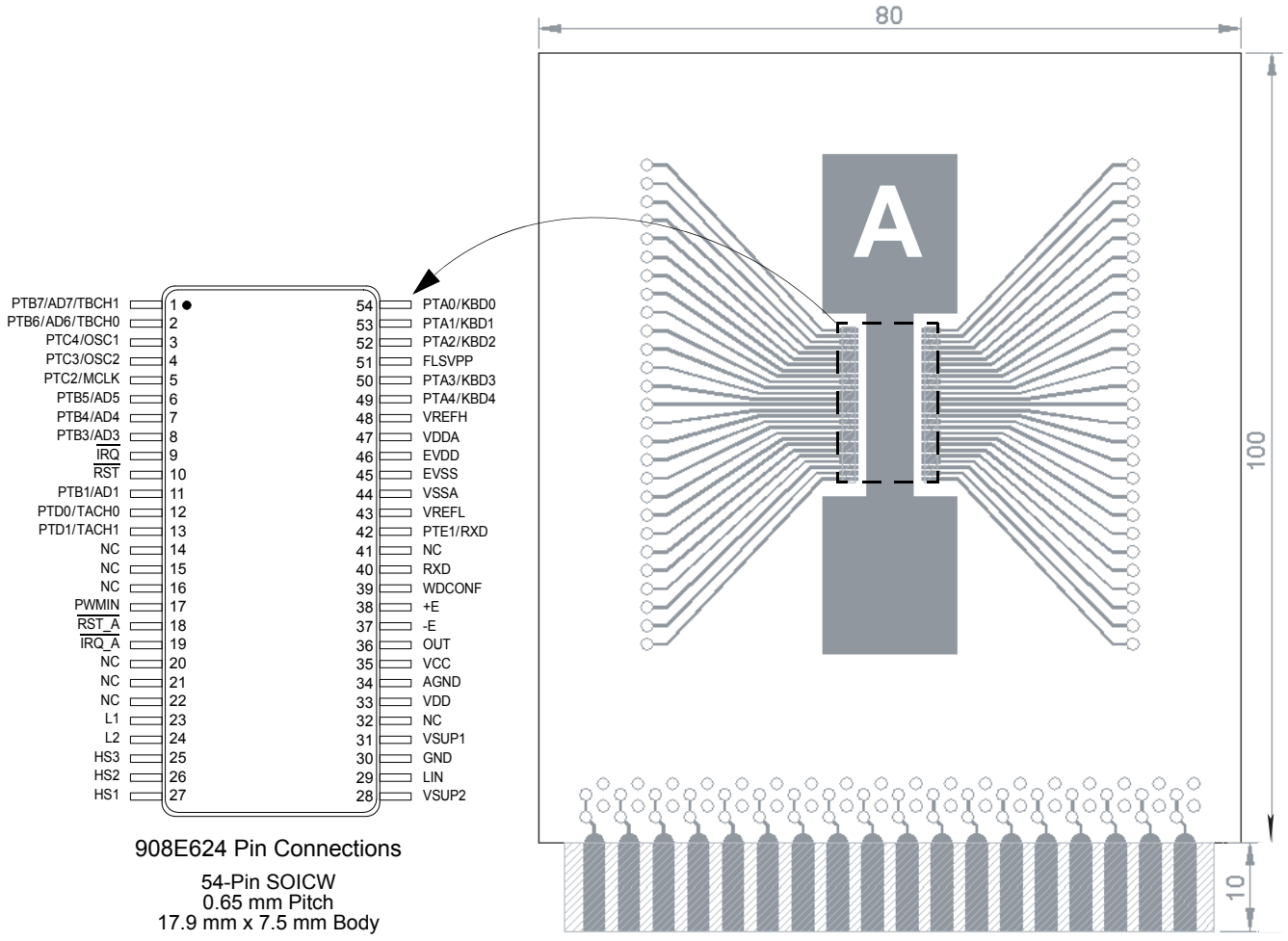

Figure 22. Surface Mount for SOIC Wide Body Non-exposed Pad

Device on Thermal Test Board

Material:	Single layer printed circuit board FR4, 1.6 mm thickness Cu traces, 0.07 mm thickness
Outline:	80 mm x 100 mm board area, including edge connector for thermal testing
Area **A**:	Cu heat-spreading areas on board surface
Ambient Conditions:	Natural convection, still air

Table 17. Thermal Resistance Performance

Pin Resistance	Area A (mm^2)	1 = Power Chip, 2 = Logic Chip (°C/W)		
		m **= 1,** ***n*** **= 1**	***m*** **= 1, n = 2** ***m*** **= 2, n = 1**	***m*** **= 2,** ***n*** **= 2**
$R_{\theta JAmn}$	0	58	48	53
	300	56	46	51
	600	54	45	50

$R_{\theta JAmn}$ is the thermal resistance between die junction and ambient air.

This device is a dual die package. Index *m* indicates the die that is heated. Index *n* refers to the number of the die where the junction temperature is sensed.

REVISION HISTORY

REVISION	DATE	DESCRIPTION OF CHANGES
7.0	5/2006	• Implemented Revision History page • Added Pb-Free package option (Suffix EW) and higher Soldering temperature • Added “Y” temperature (T_J -40°C to 125°C) code option (MM908E624AYEW) and updated condition statement for Static and Dynamic Electrical Characteristics • Corrected Figure 11, Operating Modes and Transitions (“STOP command” for transition from Normal to Stop state) • Updated Figure 21, PCB Layout Recommendations, comment NC Pin used for signal routing • Updated Table 15, Component Value Recommendation • Corrected Figure 23, Device on Thermal Test Board • Removed reference to Note 11, Voltage Regulator - Dropout Voltage • Added comment “LIN in recessive state” to Supply Current Range in Stop Mode and Sleep Mode • Updated format to match current data sheet standard. • Added Figure 10, Power On Reset and Normal Request Timeout Timing • Added LIN P/L details • Made clarifications on Max Ratings Table for T_A and T_J Thermal Ratings and the accompanying Note
8.0	3/2007	• Removed “Advance Information” watermark from first page.
9.0	9/2010	• Changed Peak Package Reflow Temperature During Reflow(3)(5) description. • Added note (5)
10.0	8/2011	• Deleted MM908E624ACDWB/R2 • Added MM908E624ACPEW/R2 and MM908E624AYPEW/R2 • Update Freescale form and style. • Updated package drawing
11.0	4/2012	• Removed part number MM908E624ACEW/ R2 and MM908E624AYEW/ R2. • Update Freescale form and style.

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